

November 2013

### FDPF035N06B

# N-Channel PowerTrench<sup>®</sup> MOSFET 60 V, 88 A, 3.5 m $\Omega$

### **Features**

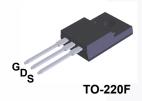
- $R_{DS(on)}$  = 2.91 m $\Omega$  ( Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 88 A
- Low FOM R<sub>DS(on)</sub>\*Q<sub>G</sub>
- · Low Reverse Recovery Charge, Qrr
- · Soft Reverse Recovery Body Diode
- Enables Highly Efficiency in Synchronous Rectification
- · Fast Switching Speed
- · 100% UIL Tested
- · RoHS Compliant

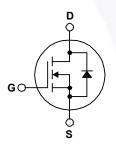
### Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

### **Applications**

- · Synchronous Rectification for ATX / Server / Telecom PSU
- · Battery Protection Circuit
- · Motor Drives and Uninterruptible Power Supplies
- · Renewable System





### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol		Parameter		
$V_{DSS}$	Drain to Source Voltage		60	V
$V_{GSS}$	Gate to Source Voltage		±20	V
	Drain Current	- Continuous (T <sub>C</sub> = 25°C, Silicon Limited)	88	Α
'D	Dialii Cuiteiii	- Continuous (T <sub>C</sub> = 100°C, Silicon Limited)	62	A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	352	Α
E <sub>AS</sub>	Single Pulsed Avalanche E	Single Pulsed Avalanche Energy (Note 2)		
dv/dt	Peak Diode Recovery dv/dt	Peak Diode Recovery dv/dt (Note 3)		V/ns
D	Power Dissipation	$(T_C = 25^{\circ}C)$	46.3	W
$P_{D}$	- Derate Above 25°C		0.31	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Ten	-55 to +175	οС	
T <sub>L</sub>	Maximum Lead Temperatu	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		

### **Thermal Characteristics**

Symbol	Parameter FDPF035N06B_F152		
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max. 3.24		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. 62.5		C/VV

### **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDPF035N06B_F152	FDPF035N06B	TO-220F	Tube	N/A	N/A	50 units

### **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	eteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C	-	0.03	-	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2	-	4	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 88 A	-	2.91	3.5	mΩ
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 88 A	-	176	-	S

### **Dynamic Characteristics**

_						
C <sub>iss</sub>	Input Capacitance	V = 20 V V = 0 V	-	6035	8030	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1  MHz	-	1685	2240	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 1011 12	-	55	-	pF
C <sub>oss(er)</sub>	Energy Related Output Capacitance	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	-	2619	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	76	99	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	$V_{DS} = 30 \text{ V}, I_{D} = 100 \text{ A},$	-	29	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10 V	-	12	-	nC
V <sub>plateau</sub>	Gate Plateau Volatge	(Note 4)	-	5.2	-	V
Q <sub>sync</sub>	Total Gate Charge Sync.	V <sub>DS</sub> = 0 V, I <sub>D</sub> = 50 A	-	67.3	-	nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	-	92.4	-	nC
ESR	Equivalent Series Resistance (G-S)	f = 1 MHz	-	2.0	-	Ω

### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time			-/	32	74	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 30 \text{ V}, I_D = 100 \text{ A},$		-	33	76	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS}$ = 10 V, $R_{G}$ = 4.7 $\Omega$		/ -	56	122	ns
t <sub>f</sub>	Turn-Off Fall Time		(Note 4)	-	23	56	ns

### **Drain-Source Diode Characteristics**

Is	Maximum Continuous Drain to Source Diode Forward Current			-	88	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	352	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 88 A	-	-	1.25	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 100 A,	-	71	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	78	-	nC

- **Notes:**1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 3 mH,  $I_{AS}$  = 20 A, starting  $T_J$  = 25°C.
- 3. I\_{SD}  $\leq$  100 A, di/dt  $\leq$  200 A/µs, V\_{DD}  $\leq$  BV\_DSS, starting T\_J = 25°C.
- 4. Essentially independent of operating temperature typical characteristics.

### **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

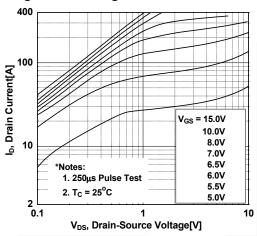


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

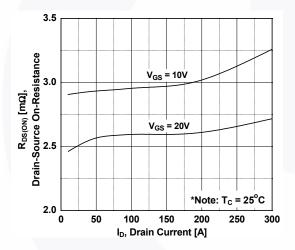


Figure 5. Capacitance Characteristics

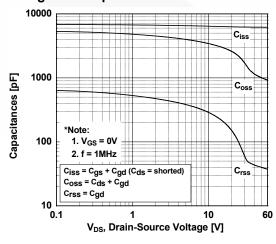


Figure 2. Transfer Characteristics

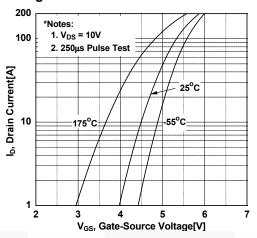


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

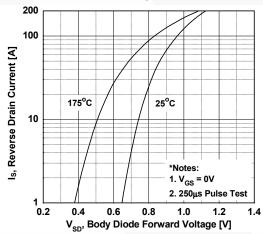
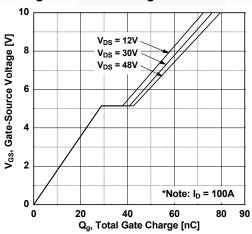


Figure 6. Gate Charge Characteristics



### **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

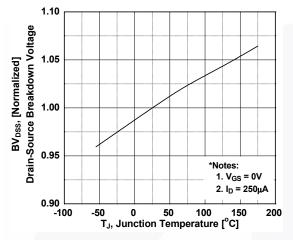


Figure 9. Maximum Safe Operating Area

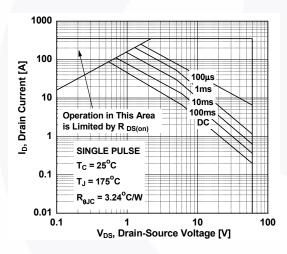


Figure 11. Eoss vs. Drain to Source Voltage

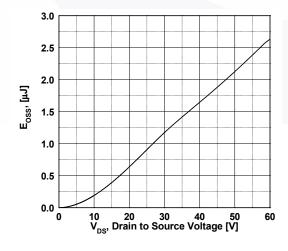


Figure 8. On-Resistance Variation vs. Temperature

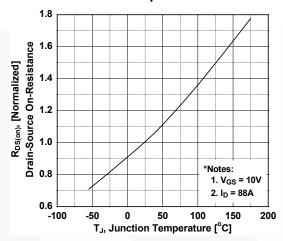


Figure 10. Maximum Drain Current vs. Case Temperature

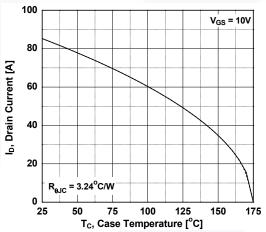
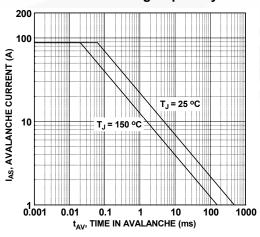
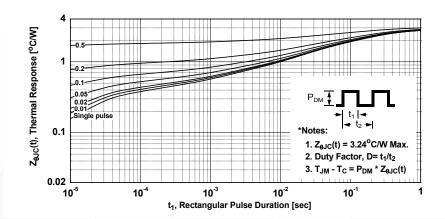


Figure 12. Unclamped Inductive Switching Capability



### **Typical Performance Characteristics** (Continued)





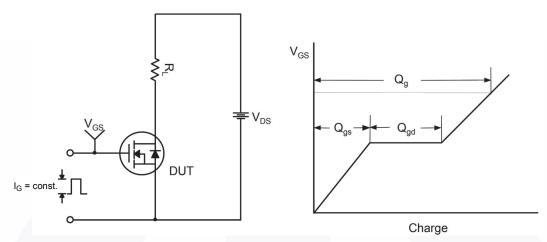


Figure 14. Gate Charge Test Circuit & Waveform

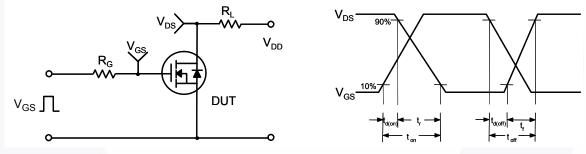


Figure 15. Resistive Switching Test Circuit & Waveforms

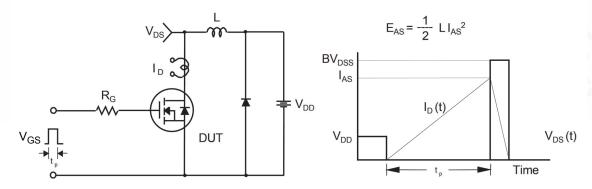


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms

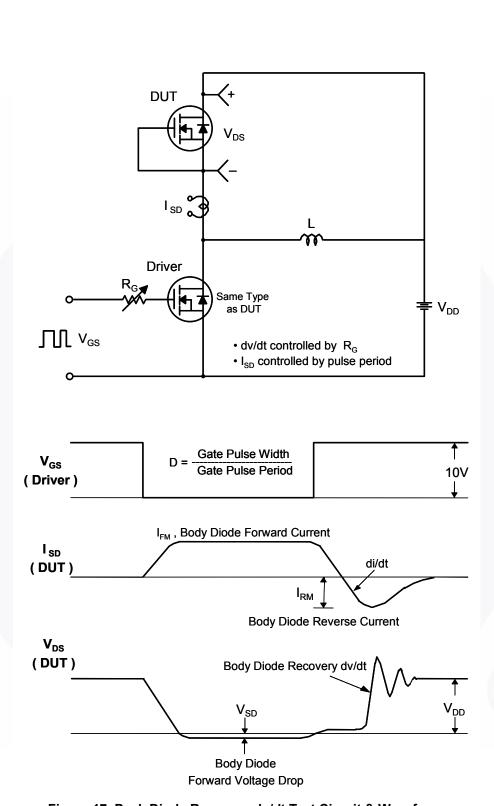


Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

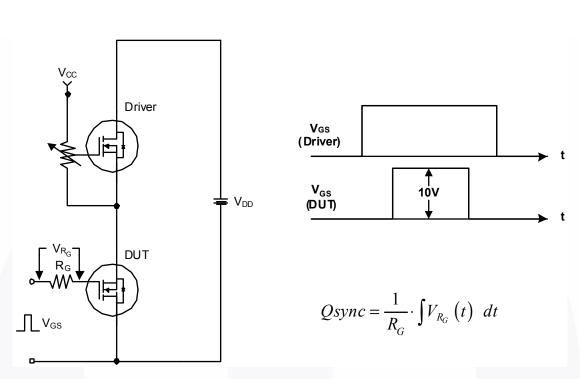


Figure 18. Total Gate Charge Qsync. Test Circuit & Waveforms

### **Mechanical Dimensions**

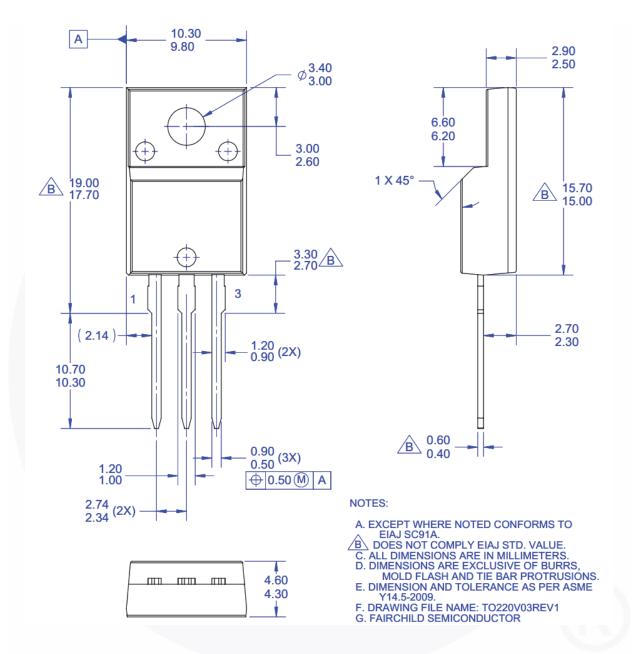


Figure 19. TO220, Molded, 3-Lead, Full Pack, EIAJ SC91, Takcheong

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